



MICRF002/RF022

300-440MHz QwikRadio® ASK Receiver



General Description

The MICRF002 is a single chip ASK/OOK (ON-OFF Keyed) RF receiver IC. This device is a true “antenna-in to data-out” monolithic device. All RF and IF tuning is accomplished automatically within the IC which eliminates manual tuning and reduces production costs. The result is a highly reliable yet low cost solution.

The MICRF002 is a fully featured part in 16-pin packaging, the MICRF022 is the same part packaged in 8-pin packaging with a reduced feature set (see “Ordering Information” for more information).

The MICRF002 is an enhanced version of the MICRF001 and MICRF011. The MICRF002 provides two additional functions over the MICRF001/011, (1) a Shutdown pin, which may be used to turn the device off for duty-cycled operation, and (2) a “Wake-up” output, which provides an output flag indicating when an RF signal is present. These features make the MICRF002 ideal for low and ultra-low power applications, such as RKE and remote controls.

All IF filtering and post-detection (demodulator) data filtering is provided within the MICRF002, so no external filters are necessary. One of four demodulator filter bandwidths may be selected externally by the user.

The MICRF002 offer two modes of operation; fixed-mode (FIX) and sweep-mode (SWP). In fixed-mode the MICRF002 functions as a conventional superhet receiver. In sweep-mode the MICRF002 employs a patented sweeping function to sweep a wider RF spectrum. Fixed-mode provides better selectivity and sensitivity performance and sweep-mode enables the MICRF002 to be used with low cost, imprecise transmitters.

Data sheets and support documentation can be found on Micrel’s web site at: www.micrel.com.

Features

- 300MHz to 440MHz frequency range
- Data-rate up to 10kbps (fixed-mode)
- Low Power Consumption
- 2.2mA fully operational (315MHz)
- 0.9µA in shutdown
- 220µA in polled operation (10:1 duty-cycle)
- Wake-up output flag to enable decoders and microprocessors
- Very low RF re-radiation at the antenna
- Highly integrated with extremely low external part count

Applications

- Automotive remote keyless entry (RKE)
- Remote controls
- Remote fan and light control
- Garage door and gate openers

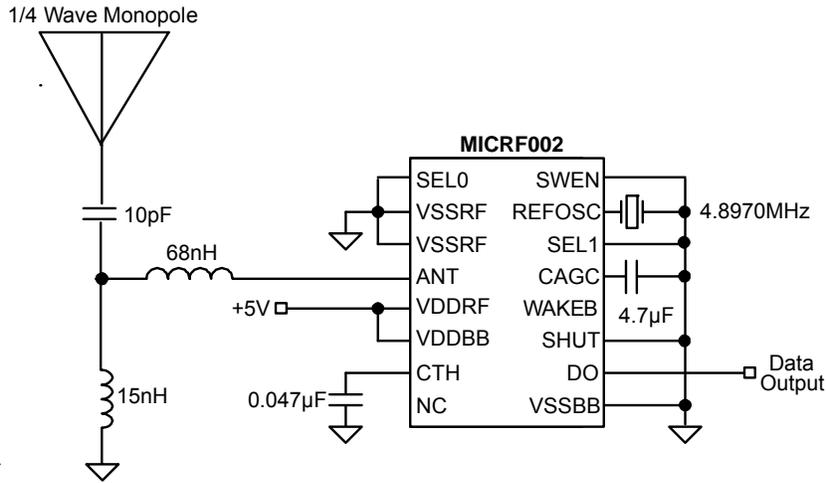
Ordering Information

Part Number	Demodulator Bandwidth	Operating Mode	Shutdown	WAKEB Output Flag	Package	Lead Finish
MICRF002YM	User Programmable	Fixed or Sweep	Yes	Yes	16-Pin SOIC	Pb-Free
MICRF022YM-SW48	5000Hz	Sweep	No	Yes	8-Pin SOIC	Pb-Free
MICRF022YM-FS12	1250Hz	Fixed	Yes	No	8-Pin SOIC	Pb-Free
MICRF022YM-FS24	2500Hz	Fixed	Yes	No	8-Pin SOIC	Pb-Free
MICRF022YM-FS48	5000Hz	Fixed	Yes	No	8-Pin SOIC	Pb-Free

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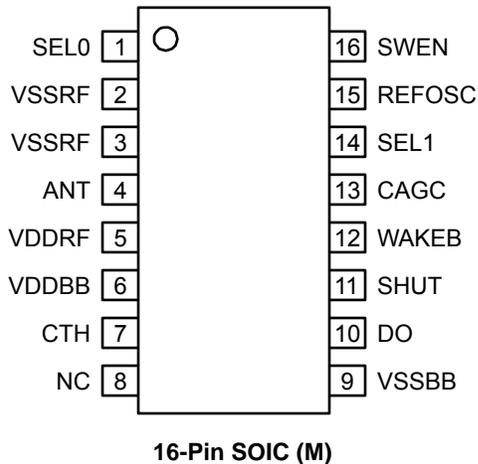
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Typical Application

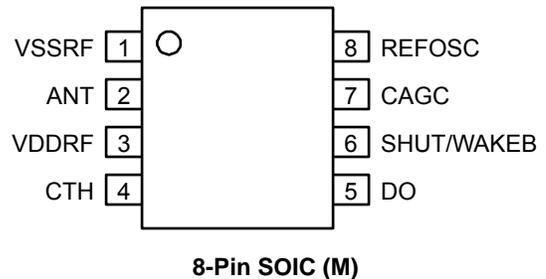


315MHz 800bps On-Off Keyed Receiver

Pin Configuration



16-Pin SOIC (M)



8-Pin SOIC (M)

8-Pin Options

The standard 16-pin package allows complete control of all configurable features. Some reduced function 8-pin versions are also available, see "Ordering Information" on page 1.

For high-volume applications additional customized 8-pin devices can be produced. SWEN, SEL0 and SEL1 pins are internally bonded to reduce the pin count; pin 6 may be configured as either SHUT or WAKEB

SEL0	SEL1	Demodulator Bandwidth	
		Sweep-Mode	Fixed-Mode
1	1	5000Hz	10000Hz
0	1	2500Hz	5000Hz
1	0	1250Hz	2500Hz
0	0	625Hz	1250Hz

Table 1. Nominal Demodulator Filter Bandwidth vs. SEL0, SEL1 and Operating Mode

Pin Description

Pin Number SOIC-16	Pin Number SOIC-8	Pin Name	Pin Name
1	–	SEL0	Bandwidth Selection Bit 0 (Digital Input): Used in conjunction with SEL1 to set the desired demodulator filter bandwidth. See Table 1. Internally pulled-up to VDDRF.
2, 3	1	VSSRF	RF Power Supply: Ground return to the RF section power supply.
4	2	ANT	Antenna (Analog Input): For optimal performance the ANT pin should be impedance matched to the antenna. See “Applications Information” for information on input impedance and matching techniques.
5	3	VDDRF	RF Power Supply: Positive supply input for the RF section of the IC.
6	–	VDDBB	Base-Band Power Supply: Positive supply input for the baseband section (digital section) of the IC.
7	4	CTH	Data Slicing Threshold Capacitor (Analog I/O): Capacitor connected to this pin extracts the dc average value from the demodulated waveform which becomes the reference for the internal data slicing comparator.
8	–	NC	Not internally connected
9	–	VSSBB	Base-Band Power Supply: Ground return to the baseband section power supply.
10	5	DO	Data Output (Digital Output)
11	6	SHUT	Shutdown (Digital Input): Shutdown-mode logic-level control input. Pull low to enable the receiver. Internally pulled-up to VDDRF.
12	–	WAKEB	Wakeup (Digital Output): Active-low output that indicates detection of an incoming RF signal.
13	7	CAGC	Automatic Gain Control (Analog I/O): Connect an external capacitor to set the attack/decay rate of the on-chip automatic gain control.
14	–	SEL1	Bandwidth Selection Bit 1 (Digital Input): Used in conjunction with SEL0 to set the desired demodulator filter bandwidth. See Table 1. Internally pulled-up to VDDRF.
15	8	REFOSC	Reference Oscillator: Timing reference, sets the RF receive frequency.
16	–	SWEN	Sweep-Mode Enable (Digital Input): Sweep- or Fixed-mode operation control input. SWEN high= sweep mode; SWEN low = conventional superheterodyne receiver. Internally pulled-up to VDDRF.

Absolute Maximum Ratings⁽¹⁾

Supply Voltage (V_{DDRF}, V_{DDBB})	+7V
Input/Output Voltage ($V_{I/O}$)	$V_{SS}-0.3$ to $V_{DD}+0.3$
Junction Temperature (T_J)	+150°C
Storage Temperature (T_S)	-65°C to 150°C
Lead Temperature (soldering, 10 sec.)	260°C
ESD Rating ⁽³⁾	

Operating Ratings⁽²⁾

Supply Voltage (V_{DDRF}, V_{DDBB})	+4.75V to +5.5V
RF Frequency Range	300MHz to 440MHz
Data Duty-Cycle	20% to 80%
Reference Oscillator Input Range	0.1V _{PP} to 1.5V _{PP}
Ambient Temperature (T_A)	-40°C to +85°C

Electrical Characteristics⁽⁴⁾

$V_{DDRF} = V_{DDBB} = V_{DD}$ where $+4.75V \leq V_{DD} \leq 5.5V$, $V_{SS} = 0V$; $C_{AGC} = 4.7\mu F$, $C_{TH} = 100nF$; $SEL0 = SEL1 = V_{SS}$; fixed mode ($SWEN = V_{SS}$); $f_{REFOSC} = 4.8970MHz$ (equivalent to $f_{RF} = 315MHz$); data-rate = 1kbps (Manchester encoded). $T_A = 25^\circ C$, **bold** values indicate $-40^\circ C \leq T_A \leq +85^\circ C$; current flow into device pins is positive; unless noted.

Symbol	Parameter	Condition	Min	Typ	Max	Units
I_{OP}	Operating Current	continuous operation, $f_{RF} = 315MHz$		2.2	3.2	mA
		polled with 10:1 duty cycle, $f_{RF} = 315MHz$		220		μA
		continuous operation, $f_{RF} = 433.92MHz$		3.5		mA
		polled with 10:1 duty cycle, $f_{RF} = 433.92MHz$		350		μA
I_{STBY}	Standby Current	$V_{SHUT} = V_{DD}$		0.9		μA
RF Section, IF Section						
	Receiver Sensitivity (Note 4)	$f_{RF} = 315MHz$		-97		dBm
		$f_{RF} = 433.92MHz$		-95		dBm
f_{IF}	IF Center Frequency	Note 6		0.86		MHz
f_{BW}	IF Bandwidth	Note 6		0.43		MHz
	Maximum Receiver Input	$R_{SC} = 50\Omega$		-20		dBm
	Spurious Reverse Isolation	ANT pin, $R_{SC} = 50\Omega$, Note 5		30		μV_{RMS}
	AGC Attack to Decay Ratio	$t_{ATTACK} \div t_{DECAY}$		0.1		
	AGC Leakage Current	$T_A = +85^\circ C$		± 100		nA
Reference Oscillator						
Z_{REFOSC}	Reference Oscillator Input Impedance	Note 8		290		k Ω
	Reference Oscillator Source Current			5.2		μA
Demodulator						
Z_{CTH}	CTH Source Impedance	Note 7		145		k Ω
$I_{ZCTH(LEAK)}$	CTH Leakage Current	$T_A = +85^\circ C$		± 100		nA
	Demodulator Filter Bandwidth Sweep Mode (SWEN = VDD or OPEN) Note 6	$V_{SEL0} = V_{DD}$. $V_{SEL1} = V_{DD}$		4000		Hz
		$V_{SEL0} = V_{SS}$. $V_{SEL1} = V_{DD}$		2000		Hz
		$V_{SEL0} = V_{DD}$. $V_{SEL1} = V_{SS}$		1000		Hz
		$V_{SEL0} = V_{SS}$. $V_{SEL1} = V_{SS}$		500		Hz
	Demodulator Filter Bandwidth Fixed Mode (SWEN = VSS) Note 6	$V_{SEL0} = V_{DD}$. $V_{SEL1} = V_{DD}$		8000		Hz
		$V_{SEL0} = V_{SS}$. $V_{SEL1} = V_{DD}$		4000		Hz
		$V_{SEL0} = V_{DD}$. $V_{SEL1} = V_{SS}$		2000		Hz
		$V_{SEL0} = V_{SS}$. $V_{SEL1} = V_{SS}$		1000		Hz

Symbol	Parameter	Condition	Min	Typ	Max	Units
Digital/Control Section						
V _{IN(high)}	Input-High Voltage	SEL0, SEL1, SWEN			0.8	V _{DD}
V _{IN(low)}	Input-Low Voltage	SEL0, SEL1, SWEN	0.2			V _{DD}
I _{OUT}	Output Current	DO, WAKEB pins, push-pull		10		μA
V _{OUT(high)}	Output High Voltage	DO, WAKEB pins, I _{OUT} = -1μA	0.9			V _{DD}
V _{OUT(low)}	Output Low Voltage	DO, WAKEB pins, I _{OUT} = +1μA			0.1	V _{DD}
t _R , t _F	Output Rise and Fall Times	DO, WAKEB pins, C _{LOAD} = 15pF		10		μs

Notes:

- Exceeding the absolute maximum rating may damage the device.
- The device is not guaranteed to function outside its operating rating.
- Devices are ESD sensitive, use appropriate ESD precautions. Meets class 1 ESD test requirements, (human body model HBM), in accordance with MIL-STD-883C, method 3015. Do not operate or store near strong electrostatic fields.
- Sensitivity is defined as the average signal level measured at the input necessary to achieve 10-2 BER (bit error rate). The RF input is assumed to be matched to 50Ω.
- Spurious reverse isolation represents the spurious components which appear on the RF input pin (ANT) measured into 50Ω with an input RF matching network.
- Parameter scales linearly with reference oscillator frequency f_r.** For any reference oscillator frequency other than 4.8970MHz, compute new parameter value as the ratio:

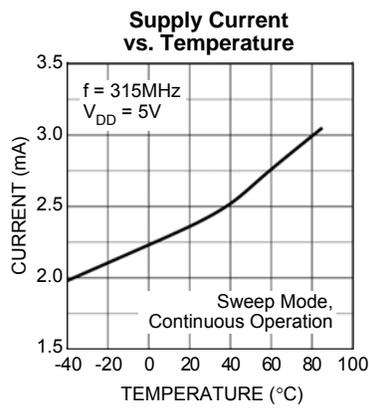
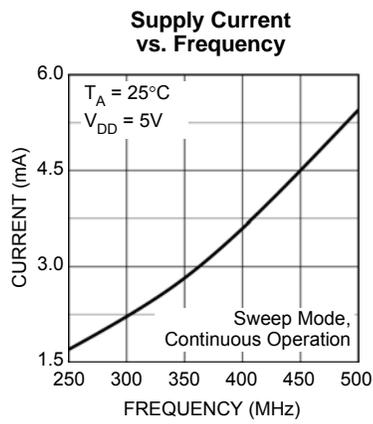
$$\frac{f_{\text{REFOSC}} \text{MHz}}{4.8970\text{MHz}} \times (\text{parameter value at } 4.8970\text{MHz})$$

- Parameter scales inversely with reference oscillator frequency f_r.** For any reference oscillator frequency other than 4.8970MHz, compute new parameter value as the ratio:

$$\frac{4.8970\text{MHz}}{f_{\text{REFOSC}} \text{MHz}} \times (\text{parameter value at } 4.8970\text{MHz})$$

- Series resistance of the resonator (ceramic resonator or crystal) should be minimized to the extent possible. In cases where the resonator series resistance is too great, the oscillator may oscillate at a diminished peak-to-peak level, or may fail to oscillate entirely. Micrel recommends that series resistances for ceramic resonators and crystals not exceed 50Ω and 100Ω respectively. Refer to Application Hint 35 for crystal recommendations.

Typical Characteristics



Functional Diagram

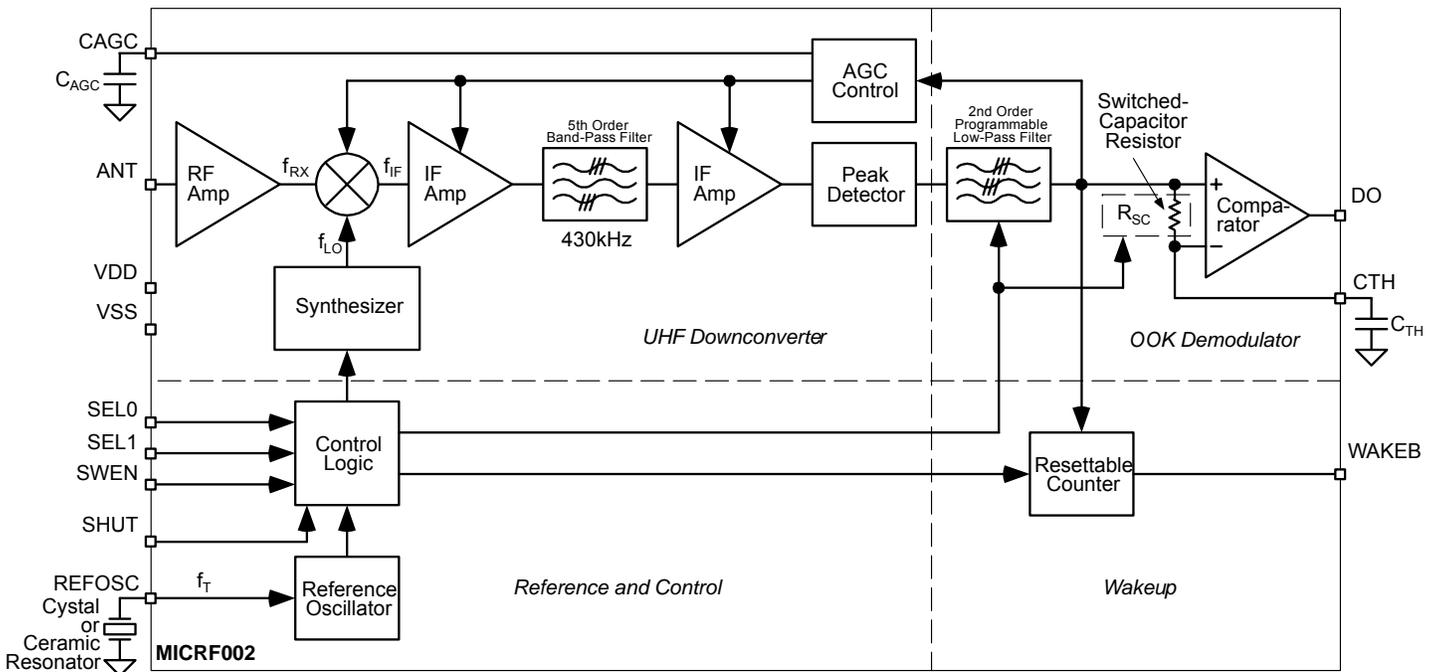


Figure 1. MICRF002 Block Diagram

Application Information and Functional Description

Refer to Figure 1 “MICRF002 Block Diagram”. Identified in the block diagram are the four sections of the IC: UHF Downconverter, OOK Demodulator, Reference and Control, and Wakeup. Also shown in the figure are two capacitors (C_{TH}, C_{AGC}) and one timing component, usually a crystal or ceramic resonator. With the exception of a supply decoupling capacitor, and antenna impedance matching network, these are the only external components needed by the MICRF002 to assemble a complete UHF receiver.

For optimal performance is highly recommended that the MICRF002 is impedance matched to the antenna, the matching network will add an additional two or three components.

Four control inputs are shown in the block diagram: SEL0, SEL1, SWEN, and SHUT. Using these logic inputs, the user can control the operating mode and selectable features of the IC. These inputs are CMOS compatible, and are internally pulled-up. IF Bandpass Filter Roll-off response of the IF Filter is 5th order, while the demodulator data filter exhibits a 2nd order response.

Design Steps

The following steps are the basic design steps for using the MICRF002 receiver:

1. Select the operating mode (sweep or fixed)
2. Select the reference oscillator
3. Select the C_{TH} capacitor
4. Select the C_{AGC} capacitor
5. Select the demodulator filter bandwidth

Step 1: Selecting the Operating Mode

Fixed-Mode Operation

For applications where the transmit frequency is accurately set (that is, applications where a SAW or crystal-based transmitter is used) the MICRF002 may be configured as a standard superheterodyne receiver (fixed mode). In fixed-mode operation the RF bandwidth is narrower making the receiver less susceptible to interfering signals. Fixed mode is selected by connecting SWEN to ground.

Sweep-Mode Operation

When used in conjunction with low-cost L-C transmitters the MICRF002 should be configured in sweep-mode. In sweep-mode, while the topology is still superheterodyne, the LO (local oscillator) is swept over a range of frequencies at rates greater than the data rate. This technique effectively increases the RF bandwidth of the

MICRF002, allowing the device to operate in applications where significant transmitter-receiver frequency misalignment may exist. The transmit frequency may vary up to ±0.5% over initial tolerance, aging, and temperature. In sweep-mode a band approximately 1.5% around the nominal transmit frequency is captured. The transmitter may drift up to ±0.5% without the need to retune the receiver and without impacting system performance.

The swept-LO technique does not affect the IF bandwidth, therefore noise performance is not degraded relative to fixed-mode. The IF bandwidth is 430kHz whether the device is operating in fixed- or sweep-mode. Due to limitations imposed by the LO sweeping process, the upper limit on data rate in sweep mode is approximately 5.0kbps.

Similar performance is not currently available with crystalbased superheterodyne receivers which can operate only with SAW- or crystal-based transmitters. In sweep-mode, a range reduction will occur in installations where there is a strong interferer in the swept RF band. This is because the process indiscriminately includes all signals within the sweep range. An MICRF002 may be used in place of a superregenerative receiver in most applications.

Step 2: Selecting the Reference Oscillator

All timing and tuning operations on the MICRF002 are derived from the internal Colpitts reference oscillator. Timing and tuning is controlled through the REFOSC pin in one of three ways:

1. Connect a ceramic resonator
2. Connect a crystal
3. Drive this pin with an external timing signal

The specific reference frequency required is related to the system transmit frequency and to the operating mode of the receiver as set by the SWEN pin.

Crystal or Ceramic Resonator Selection

Do not use resonators with integral capacitors since capacitors are included in the IC, also care should be taken to ensure low ESR capacitors are selected. Application Hint 34 and Application Hint 35 provide additional information and recommended sources for crystals and resonators.

If operating in fixed-mode, a crystal is recommended. In sweep-mode either a crystal or ceramic resonator may be used. When a crystal of ceramic resonator is used the minimum voltage is 300mV_{PP}. If using an externally applied signal it should be AC-coupled and limited to the operating range of 0.1V_{PP} to 1.5V_{PP}.

Selecting Reference Oscillator Frequency f_T (Fixed-Mode)

As with any superheterodyne receiver, the mixing between the internal LO (local oscillator) frequency f_{LO} and the incoming transmit frequency f_{TX} ideally must equal the IF center frequency. Equation 1 may be used to compute

the appropriate f_{LO} for a given f_{TX} :

$$(1) \quad f_{LO} = f_{TX} \pm \left(0.86 \frac{f_{TX}}{315} \right)$$

Frequencies f_{TX} and f_{LO} are in MHz. Note that two values of f_{LO} exist for any given f_{TX} , distinguished as “high-side mixing” and “low-side mixing”. High-side mixing results in an image frequency above the frequency of interest and low-side mixing results in a frequency below.

After choosing one of the two acceptable values of f_{LO} , use Equation 2 to compute the reference oscillator frequency f_T :

$$(2) \quad f_T = \frac{f_{LO}}{64.5}$$

Frequency f_T is in MHz. Connect a crystal of frequency f_T to REFOSC on the MICRF002. Four-decimal-place accuracy on the frequency is generally adequate. The following table identifies f_T for some common transmit frequencies when the MICRF002 is operated in fixed mode.

Transmit Frequency f_{TX}	Reference Oscillator Frequency f_T
315MHz	4.8970MHz
390MHz	6.0630MHz
418MHz	6.4983MHz
433.92MHz	6.7458MHz

Table 2. Fixed-Mode Recommended Reference Oscillator Values for Typical Transmit Frequencies (high-side mixing)

Selecting REFOSC Frequency f_T (Sweep-Mode)

Selection of the reference oscillator frequency f_T in sweep-mode is much simpler than in fixed mode due to the LO sweeping process. Also, accuracy requirements of the frequency reference component are significantly relaxed.

In sweep-mode, f_T is given by Equation 3:

$$(3) \quad f_T = \frac{f_{LO}}{64.25}$$

In sweep-mode a reference oscillator with frequency accurate to two-decimal-places is generally adequate. A crystal may be used and may be necessary in some cases if the transmit frequency is particularly imprecise.

Transmit Frequency f_{TX}	Reference Oscillator Frequency f_T
315MHz	4.88MHz
390MHz	6.05MHz
418MHz	6.48MHz
433.92MHz	6.73MHz

Table 3. Sweep-Mode Recommended Reference Oscillator Values for Typical Transmit Frequencies

Step 3: Selecting the C_{TH} Capacitor

Extraction of the dc value of the demodulated signal for purposes of logic-level data slicing is accomplished using the external threshold capacitor C_{TH} and the on-chip switched capacitor “resistor” R_{SC}, shown in the block diagram.

Slicing level time constant values vary somewhat with decoder type, data pattern, and data rate, but typically values range from 5ms to 50ms. Optimization of the value of C_{TH} is required to maximize range.

Selecting Capacitor C_{TH}

The first step in the process is selection of a data-slicing-level time constant. This selection is strongly dependent on system issues including system decode response time and data code structure (that is, existence of data preamble, etc.). This issue is covered in more detail in Application Note 22.

The effective resistance of R_{SC} is listed in the electrical characteristics table as 145kΩ at 315MHz, this value scales linearly with frequency. Source impedance of the C_{TH} pin at other frequencies is given by Equation 4, where f_T is in MHz:

$$(4) \quad R_{SC} = 145k\Omega \frac{4.8970}{f_T}$$

τ of 5x the bit-rate is recommended. Assuming that a slicing level time constant τ has been established, capacitor C_{TH} may be computed using Equation 5:

$$(5) \quad C_{TH} = \frac{\tau}{R_{SC}}$$

A standard ±20% X7R ceramic capacitor is generally sufficient. Refer to Application Hint 42 for C_{TH} and C_{AGC} selection examples.

Step 4: Selecting the C_{AGC} Capacitor

The signal path has AGC (automatic gain control) to increase input dynamic range. The attack time constant of the AGC is set externally by the value of the C_{AGC} capacitor connected to the C_{AGC} pin of the device. To maximize system range, it is important to keep the AGC control voltage ripple low, preferably under 10mV_{PP} once the control voltage has attained its quiescent value. For this reason capacitor values of at least 0.47μF are recommended.

The AGC control voltage is carefully managed on-chip to allow duty-cycle operation of the MICRF002. When the device is placed into shutdown mode (SHUT pin pulled high), the AGC capacitor floats to retain the voltage. When operation is resumed, only the voltage droop due to capacitor leakage must be replenished. A relatively low-leakage capacitor is recommended when the devices are used in duty-cycled operation.

To further enhance duty-cycled operation, the AGC push and pull currents are boosted for approximately 10ms immediately after the device is taken out of shutdown. This compensates for AGC capacitor voltage droop and reduces the time to restore the correct AGC voltage. The current is boosted by a factor of 45.

Selecting C_{AGC} Capacitor in Continuous Mode

A C_{AGC} capacitor in the range of 0.47μF to 4.7μF is typically recommended. The value of the C_{AGC} should be selected to minimize the ripple on the AGC control voltage by using a sufficiently large capacitor. However if the capacitor is too large the AGC may react too slowly to incoming signals. AGC settling time from a completely discharged (zero-volt) state is given approximately by Equation 6:

$$(6) \quad \Delta t = 1.333C_{AGC} - 0.44$$

where:

C_{AGC} sin in μF, and Δt is in seconds.

Selecting C_{AGC} Capacitor in Duty-Cycle Mode

Voltage droop across the C_{AGC} capacitor during shutdown should be replenished as quickly as possible after the IC is enabled. As mentioned above, the MICRF002 boosts the push-pull current by a factor of 45 immediately after start-up. This fixed time period is based on the reference oscillator frequency f_T. The time is 10.9ms for f_T = 6.00MHz, and varies inversely with f_T. The value of C_{AGC} capacitor and the duration of the shutdown time period should be selected such that the droop can be replenished within this 10ms period.

Polarity of the droop is unknown, meaning the AGC voltage could droop up or down. Worst-case from a recovery standpoint is downward droop, since the AGC pull-up current is 1/10th magnitude of the pulldown current. The downward droop is replenished according to the Equation 7:

$$(7) \quad \frac{I}{C_{AGC}} = \frac{\Delta V}{\Delta t}$$

where:

I = AGC pullup current for the initial 10ms (67.5μA)

C_{AGC} = AGC capacitor value

Δt = droop recovery time

ΔV = droop voltage

For example, if user desires Δt = 10ms and chooses a 4.7μF C_{AGC}, then the allowable droop is about 144mV. Using the same equation with 200nA worst case pin leakage and assuming 1μA of capacitor leakage in the same direction, the maximum allowable Δt (shutdown time) is about 0.56s for droop recovery in 10ms.

The ratio of decay-to-attack time-constant is fixed at 10:1 (that is, the attack time constant is 1/10th of the decay time constant). Generally the design value of 10:1 is adequate

for the vast majority of applications. If adjustment is required the constant may be varied by adding a resistor in parallel with the C_{AGC} capacitor. The value of the resistor must be determined on a case by case basis.

Step 5: Selecting The Demod Filter Bandwidth

The inputs SEL0 and SEL1 control the demodulator filter bandwidth in four binary steps (625Hz to 5000Hz in sweep, 1250Hz to 10000Hz in fixed-mode), see Table 3. Bandwidth must be selected according to the application. The demodulator bandwidth should be set according to Equation 8:

$$(8) \quad \text{Demodulator bandwidth} = \frac{0.65}{\text{Shortest pulse} - \text{width}}$$

It should be noted that the values indicated in Table 1 are nominal values. The filter bandwidth scales linearly with frequency so the exact value will depend on the operating frequency. Refer to the "Electrical Characteristics" for the exact filter bandwidth at a chosen frequency.

SEL0	SEL1	Demodulator Bandwidth	
		Sweep-Mode	Fixed-Mode
1	1	5000Hz	10000Hz
0	1	2500Hz	5000Hz
1	0	1250Hz	2500Hz
0	0	625Hz	1250Hz

Table 1. Nominal Demodulator Filter Bandwidth vs. SEL0, SEL1 and Operating Mode

Additional Applications Information

In addition to the basic operation of the MICRF002 the following enhancements can be made. In particular it is strongly recommended that the antenna impedance is matched to the input of the IC.

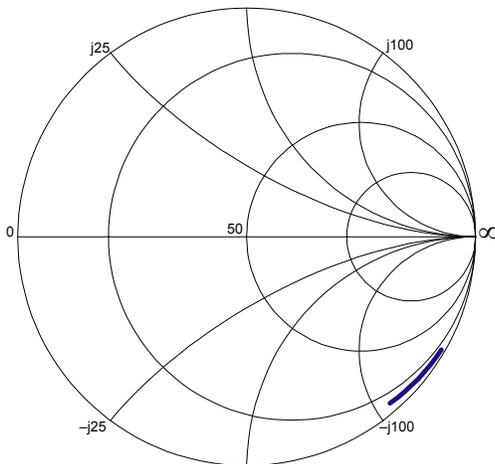
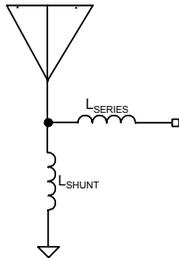
Antenna Impedance Matching

As shown in Table 4 the antenna pin input impedance is frequency dependant. The ANT pin can be matched to 50Ω with an L-type circuit. That is, a shunt inductor from the RF input to ground and another in series from the RF input to the antenna pin.

Inductor values may be different from table depending on PCB material, PCB thickness, ground configuration, and how long the traces are in the layout. Values shown were characterized for a 0.031 thickness, FR4 board, solid ground plane on bottom layer, and very short traces. MuRata and Coilcraft wire wound 0603 or 0805 surface mount inductors were tested, however any wire wound inductor with high SRF (self resonance frequency) should do the job.

Shutdown Function

Duty-cycled operation of the MICRF002 (often referred to as polling) is achieved by turning the MICRF002 on and off via the SHUT pin. The shutdown function is controlled by a logic state applied to the SHUT pin. When VSHUT is high, the device goes into low-power standby mode. This pin is pulled high internally, it must be externally pulled low to enable the receiver.



Frequency (MHz)	Z _{IN} Z11	S11	L _{SHUNT} (nH)	L _{SERIES} (nH)
300	12-j166	0.803-j0.529	15	72
305	12-j165	0.800-j0.530	15	72
310	12-j163	0.796-j0.536	15	72
315	13-j162	0.791-j0.536	15	72
320	12-j160	0.789-j0.543	15	68
325	12-j157	0.782-j0.550	12	68
330	12-j155	0.778-j0.556	12	68
335	12-j152	0.770-j0.564	12	68
340	11-j150	0.767-j0.572	15	56
345	11-j148	0.762-j0.578	15	56
350	11-j145	0.753-j0.586	12	56
355	11-j143	0.748-j0.592	12	56
360	11-j141	0.742-j0.597	10	56
365	11-j139	0.735-j0.603	10	56
370	10-j137	0.732-j0.612	12	47
375	10-j135	0.725-j0.619	12	47
380	10-j133	0.718-j0.625	10	47
385	10-j131	0.711-j0.631	10	47
390	10-j130	0.707-j0.634	10	43
395	10-j128	0.700-j0.641	10	43
400	10-j126	0.692-j0.647	10	43
405	10-j124	0.684-j0.653	10	39
410	10-j122	0.675-j0.660	10	39
415	10-j120	0.667-j0.667	10	39
420	10-j118	0.658-j0.673	10	36
425	10-j117	0.653-j0.677	10	36
430	10-j115	0.643-j0.684	10	33
435	10-j114	0.638-j0.687	10	33
440	8-j112	0.635-j0.704	8.2	33

Table 4. Input Impedance vs. Frequency

Power Supply Bypass Capacitors

V_{DDBB} and V_{DDRF} should be connected together directly at the IC pins. Supply bypass capacitors are strongly recommended. They should be connected to V_{DDBB} and V_{DDRF} and should have the shortest possible lead lengths. For best performance, connect V_{SSRF} to V_{SSBB} at the power supply only (that is, keep V_{SSBB} currents from flowing through the V_{SSRF} return path).

Increasing Selectivity with an Optional BandPass Filter

For applications located in high ambient noise environments, a fixed value band-pass network may be connected between the ANT pin and V_{SSRF} to provide additional receive selectivity and input overload protection. A minimum input configuration is included in Figure 7 it provides some filtering and necessary overload protection.

Data Squelching

During quiet periods (no signal) the data output (DO pin) transitions randomly with noise. Most decoders can discriminate between this random noise and actual data but for some system it does present a problem. There are three possible approaches to reducing this output noise:

1. Analog squelch to raise the demodulator threshold
2. Digital squelch to disable the output when data is not present
3. Output filter to filter the (high frequency) noise glitches on the data output pin.

The simplest solution is add analog squelch by introducing a small offset, or squelch voltage, on the C_{TH} pin so that noise does not trigger the internal comparator. Usually 20mV to 30mV is sufficient, and may be achieved by connecting a several-megohm resistor from the C_{TH} pin to either V_{SS} or V_{DD} , depending on the desired offset polarity. Since the MICRF002 has receiver AGC noise at the internal comparator input is always the same, set by the AGC. The squelch offset requirement does not change as the local noise strength changes from installation to installation. Introducing squelch will reduce sensitivity and also reduce range. Only introduce an amount of offset sufficient to quiet the output. Typical squelch resistor values range from 6.8M Ω to 10M Ω .

Wake-Up Function

The WAKEB output signal can be used to reduce system power consumption by enabling the rest of a system when an RF signal is present. The WAKEB is an output logic signal which goes active low when the IC detects a constant RF carrier. The wake-up function is unavailable when the IC is in shutdown mode.

To activate the Wake-Up function, a received constant RF carrier must be present for 128 counts or the internal system clock. The internal system clock is derived from the

reference oscillator and is 1/256 the reference oscillator frequency. For example:

$$f_T = 6.4\text{MHz}$$

$$f_S = f_T/256 = 25\text{kHz}$$

$$P_S = 1/f_S = 0.04\text{ms}$$

$$128 \text{ counts} \times 0.04\text{ms} = 5.12\text{ms}$$

where:

f_T = reference oscillator frequency

f_S = system clock frequency

P_S = system clock period

The Wake-Up counter will reset immediately after a detected RF carrier drops. The duration of the Wake-Up signal output is then determined by the required wake up time plus an additional RF carrier on time interval to create a wake up pulse output.

$$\text{WAKEB Output Pulse Time} = T_{\text{WAKE}} + \text{Additional RF Carrier On Time}$$

For designers who wish to use the wakeup function while squelching the output, a positive squelching offset voltage must be used. This simply requires that the squelch resistor be connected to a voltage more positive than the quiescent voltage on the C_{TH} pin so that the data output is low in absence of a transmission.

I/O Pin Interface Circuitry

Interface circuitry for the various I/O pins of the MICRF002 are diagrammed in Figures 1 through 6. The ESD protection diodes at all input and output pins are not shown.

C_{TH} Pin

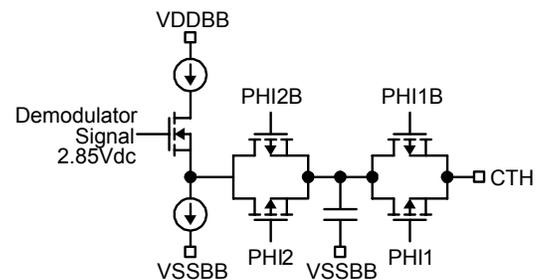


Figure 2. C_{TH} Pin

Figure 2 illustrates the C_{TH} pin interface circuit. The C_{TH} pin is driven from a P-channel MOSFET source-follower with approximately 10 μ A of bias. Transmission gates TG1 and TG2 isolate the 6.9pF capacitor. Internal control signals PHI1/PHI2 are related in a manner such that the impedance across the transmission gates looks like a "resistance" of approximately 100k Ω . The dc potential at the C_{TH} pin is approximately 1.6V

C_{AGC} Pin

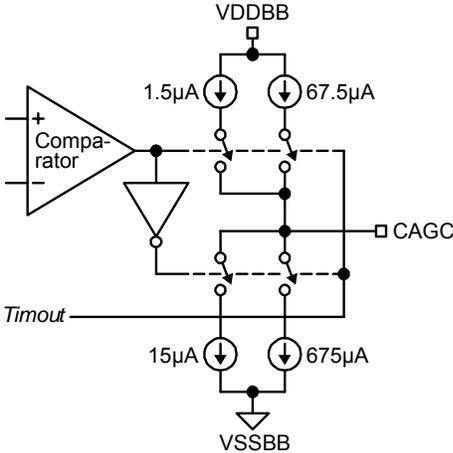


Figure 3. CAGC Pin

Figure 3 illustrates the C_{AGC} pin interface circuit. The AGC control voltage is developed as an integrated current into a capacitor C_{AGC}. The attack current is nominally 15µA, while the decay current is a 1/10th scaling of this, nominally 1.5µA, making the attack/decay time constant ratio a fixed 10:1. Signal gain of the RF/IF strip inside the IC diminishes as the voltage at C_{AGC} decreases. Modification of the attack/decay ratio is possible by adding resistance from the C_{AGC} pin to either V_{DDBB} or V_{SSBB}, as desired.

Both the push and pull current sources are disabled during shutdown, which maintains the voltage across C_{AGC}, and improves recovery time in duty-cycled applications. To further improve duty-cycle recovery, both push and pull currents are increased by 45 times for approximately 10ms after release of the SHUT pin. This allows rapid recovery of any voltage droop on C_{AGC} while in shutdown.

DO and WAKEB Pins

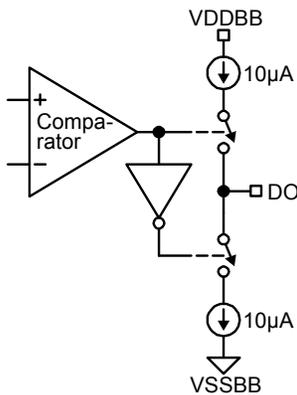


Figure 4. DO and WAKEB Pins

The output stage for DO (digital output) and WAKEB (wake-up output) is shown in Figure 4. The output is a 10µA push and 10µA pull switched-current stage. This output stage is capable of driving CMOS loads. An external buffer-

driver is recommended for driving high-capacitance loads.

REFOSC Pin

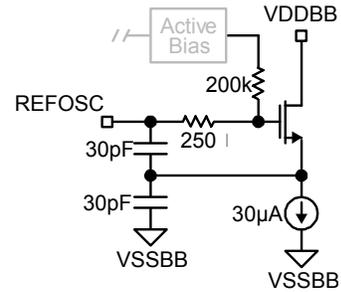


Figure 5. REFOSC Pin

The REFOSC input circuit is shown in Figure 5. Input impedance is high (200kΩ). This is a Colpitts oscillator with internal 30pF capacitors. This input is intended to work with standard ceramic resonators connected from this pin to the V_{SSBB} pin, although a crystal may be used when greater frequency accuracy is required. The nominal dc bias voltage on this pin is 1.4V.

SEL0, SEL1, SWEN, and SHUT Pins

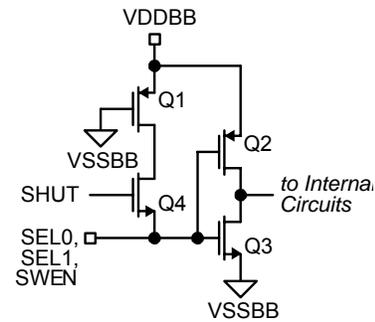


Figure 6a. SEL0, SEL1, SWEN Pins

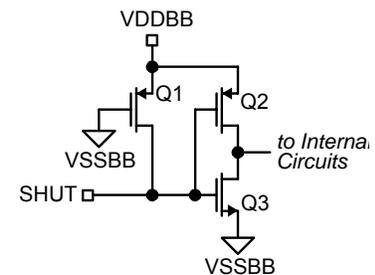
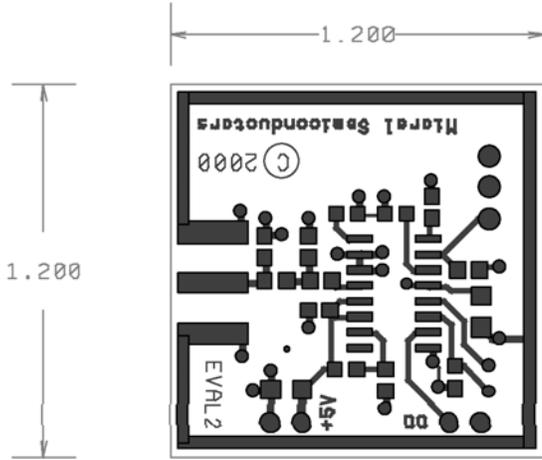


Figure 6b. SHUT Pin

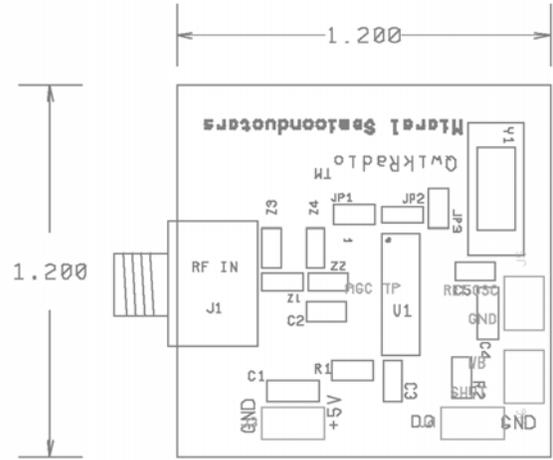
Control input circuitry is shown in Figures 6a and 6b. The standard input is a logic inverter constructed with minimum geometry MOSFETs (Q2, Q3). P-channel MOSFET Q1 is a large channel length device which functions essentially as a “weak” pullup to V_{DDBB}. Typical pull-up current is 5µA, leading to an impedance to the V_{DDBB} supply of typically 1MΩ.

PCB Layout Information

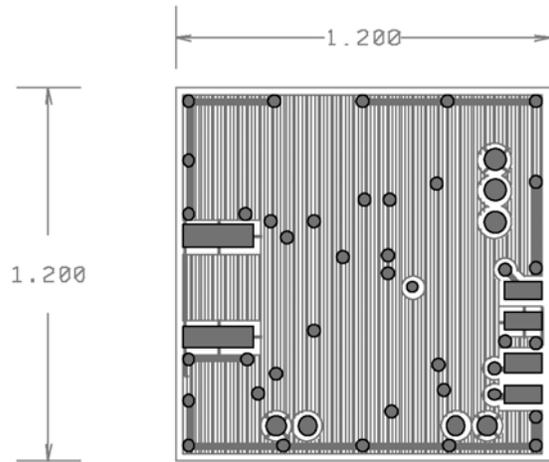
The MICRF002 evaluation board was designed and characterized using two sided 0.031 inch thick FR4 material with 1 ounce copper clad. If another type of printed circuit board material were to be substituted, impedance matching and characterization data stated in this document may not be valid. The gerber files for this board can be downloaded from the Micrel website at www.micrel.com.



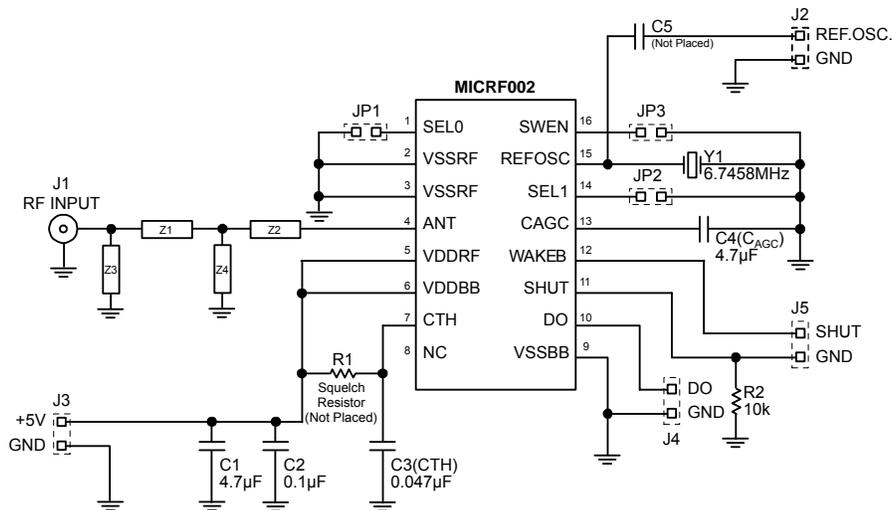
PCB Silk Screen



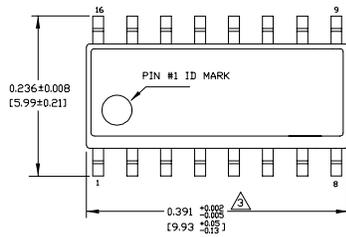
PCB Component Side Layout



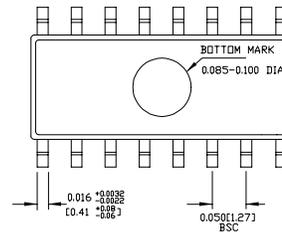
PCB Solder Side Layout



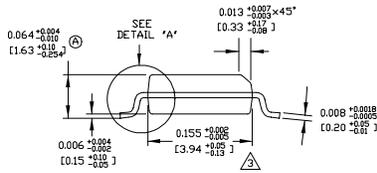
Package Information



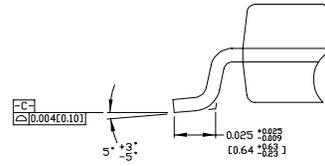
TOP VIEW



BOTTOM VIEW



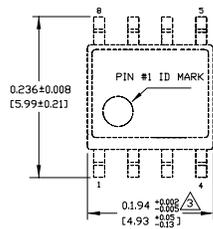
END VIEW



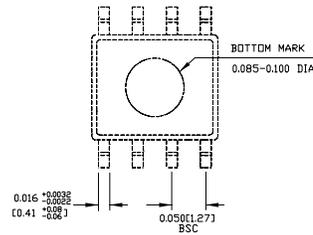
DETAIL "A"

- NOTES:
 1. DIMENSIONS ARE IN INCHES(MM).
 2. CONTROLLING DIMENSION: INCHES.
 Δ DIMENSION DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS, EITHER OF WHICH SHALL NOT EXCEED 0.010(0.25) PER SIDE.

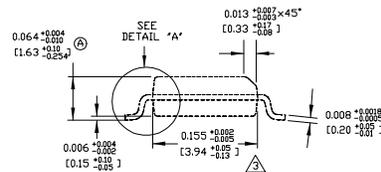
16-Pin SOIC (M)



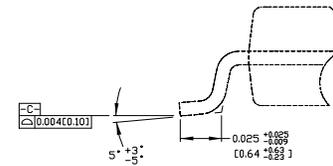
TOP VIEW



BOTTOM VIEW



END VIEW



DETAIL "A"

- NOTES:
 1. DIMENSIONS ARE IN INCHES(MM).
 2. CONTROLLING DIMENSION: INCHES.
 Δ DIMENSION DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS, EITHER OF WHICH SHALL NOT EXCEED 0.010(0.25) PER SIDE.

8-Pin SOIC (M)

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